Power MOSFET Dual N-Channel

3.1 Amps, 20 Volts

Features

- Low R_{DS(on)} for Higher Efficiency
- Logic Level Gate Drive
- Miniature ChipFET[™] Surface Mount Package Saves Board Space

Applications

• Power Management in Portable and Battery–Powered Products; i.e., Cellular and Cordless Telephones and PCMCIA Cards

MAXIMUM RATINGS ($T_A = 25^{\circ}C$ unless otherwise noted)

Rating	Symbol	5 secs	Steady State	Unit
Drain-Source Voltage	V _{DS}	20		V
Gate-Source Voltage	V _{GS}	±12		V
Continuous Drain Current $(T_J = 150^{\circ}C)$ (Note 1) $T_A = 25^{\circ}C$ $T_A = 85^{\circ}C$	I _D	±4.2 ±3.0	±3.1 ±2.2	А
Pulsed Drain Current	I _{DM}	±10		Α
Continuous Source Current (Diode Conduction) (Note 1)	I _S	1.8	0.9	А
Maximum Power Dissipation (Note 1) T _A = 25°C T _A = 85°C	P _D	2.1 1.1	1.1 0.6	W
Operating Junction and Storage Temperature Range	T _J , T _{stg}	-55 to +150		°C

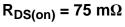
1. Surface Mounted on 1" x 1" FR4 Board.

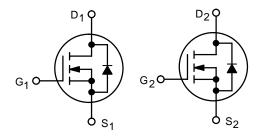


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DUAL N-CHANNEL
3.1 AMPS, 20 VOLTS





N-Channel MOSFET

N-Channel MOSFET



ChipFET CASE 1206A STYLE 2

PIN CONNECTIONS MARKING DIAGRAM D1 8 1 S1 1 O 8 7 D2 6 3 S2 3 6 6 D2 5 4 G2 4 6 5 5

A1 = Specific Device Code

ORDERING INFORMATION

Device	Package	Shipping			
NTHD5904T1 ChipFET		3000/Tape & Reel			

1

THERMAL CHARACTERISTICS

Characteristic	Symbol	Тур	Max	Unit
$\label{eq:maximum_Junction_to-Ambient} \begin{tabular}{ll} Maximum Junction-to-Ambient (Note 2) \\ t \le 5 sec \\ Steady State \end{tabular}$	R _{thJA}	50 90	60 110	°C/W
Maximum Junction–to–Foot (Drain) Steady State	R_{thJF}	30	40	°C/W

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

Characteristic	Symbol	Test Condition	Min	Тур	Max	Unit
Static	•		•	•	•	
Gate Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	0.6	_	_	V
Gate-Body Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 12 \text{ V}$	-	_	±100	nA
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 16 V, V _{GS} = 0 V	-	_	1.0	μΑ
		$V_{DS} = 16 \text{ V}, V_{GS} = 0 \text{ V},$ $T_{J} = 85^{\circ}\text{C}$	-	-	5.0	
On-State Drain Current (Note 3)	I _{D(on)}	$V_{DS} \ge 5.0 \text{ V}, V_{GS} = 4.5 \text{ V}$	10	-	_	Α
Drain-Source On-State Resistance (Note 3)	r _{DS(on)}	$V_{GS} = 4.5 \text{ V}, I_D = 3.1 \text{ A}$	-	0.065	0.075	Ω
	$V_{GS} = 2.5 \text{ V}, I_D = 2.3 \text{ A}$		-	0.115	0.143	
Forward Transconductance (Note 3)	9 _{fs}	V _{DS} = 10 V, I _D = 3.1 A	-	8.0	-	S
Diode Forward Voltage (Note 3)	V_{SD}	I _S = 0.9 A, V _{GS} = 0 V	-	0.8	1.2	V
Dynamic (Note 4)						
Total Gate Charge	Qg		_	4.0	6.0	nC
Gate-Source Charge	Q _{gs}	$V_{DS} = 10 \text{ V}, V_{GS} = 4.5 \text{ V},$ $I_{D} = 3.1 \text{ A}$	_	0.6	_	
Gate-Drain Charge	Q _{gd}		-	1.3	_	
Turn-On Delay Time	t _{d(on)}		-	12	18	ns
Rise Time	t _r	$V_{DD} = 10 \text{ V}, R_L = 10 \Omega$	-	35	55	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 1.0 \text{ A, } V_{GEN} = 4.5 \text{ V,}$ $R_G = 6 \Omega$	-	19	30	
Fall Time	t _f		-	9.0	15	
Source–Drain Reverse Recovery Time	t _{rr}	I _F = 0.9 A, di/dt = 100 A/μs	-	40	80	

Surface Mounted on 1" x 1" FR4 Board.
 Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
 Guaranteed by design, not subject to production testing.

TYPICAL ELECTRICAL CHARACTERISTICS

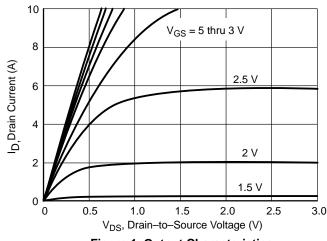


Figure 1. Output Characteristics

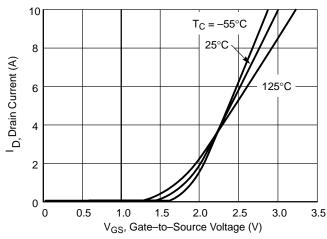


Figure 2. Transfer Characteristics

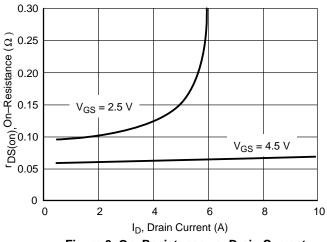


Figure 3. On-Resistance vs. Drain Current

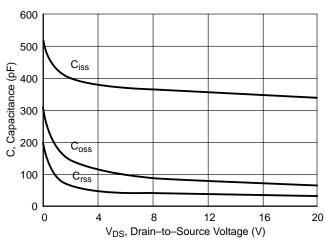
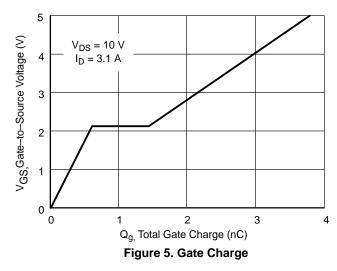


Figure 4. Capacitance



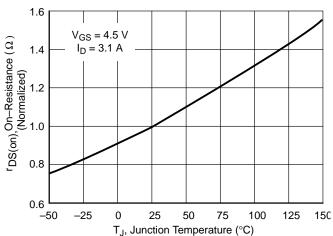
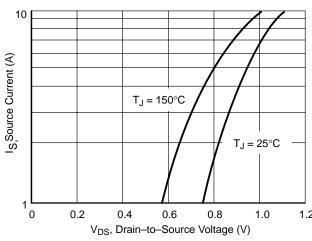


Figure 6. On–Resistance vs.
Junction Temperature

TYPICAL ELECTRICAL CHARACTERISTICS



0.20 © 0.15 0.10 0 0 1 2 3 4 5 V_{GS}, Gate-to-Source Voltage (V)

Figure 7. Source-Drain Diode Forward Voltage

Figure 8. On–Resistance vs. Gate–to–Source Voltage

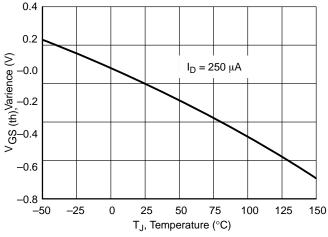


Figure 9. Threshold Voltage

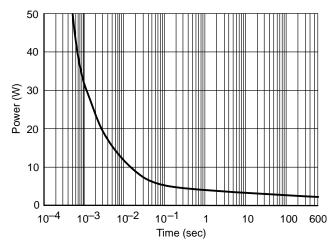


Figure 10. Single Pulse Power

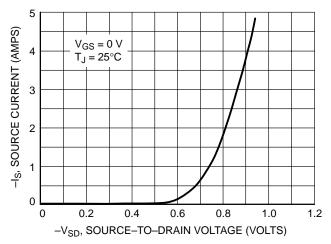


Figure 11. Diode Forward Voltage vs. Current

TYPICAL ELECTRICAL CHARACTERISTICS

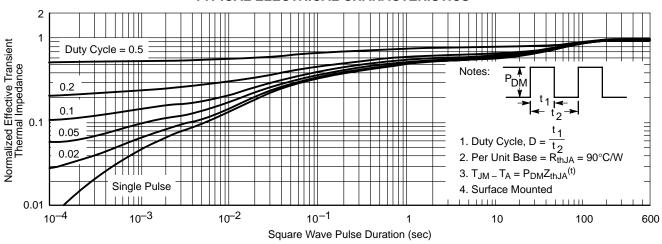


Figure 12. Normalized Thermal Transient Impedance, Junction-to-Ambient

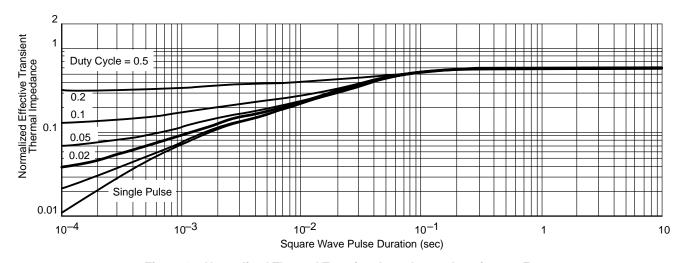
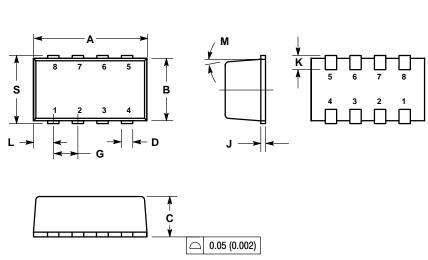


Figure 13. Normalized Thermal Transient Impedance, Junction-to-Foot

Notes

PACKAGE DIMENSIONS

ChipFET CASE 1206A-03 ISSUE C



- NOTES:
 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 2. CONTROLLING DIMENSION: MILLIMETER.
 3. MOLD GATE BURRS SHALL NOT EXCEED 0.13 MM PER SIDE.
 4. LEADFRAME TO MOLDED BODY OFFSET IN HORIZONTAL AND VERTICAL SHALL NOT EXCEED 0.08 MM.
 5. DIMENSIONS A AND B EXCLUSIVE OF MOLD GATE BURRS.
 6. NO MOLD FLASH ALLOWED ON THE TOP AND BOTTOM LEAD SURFACE.
 7. 1206A-01 AND 1206A-02 OBSOLETE. NEW STANDARD IS 1206A-03.

	MILLIMETERS		INCHES		
DIM	MIN	N MAX MIN M		MAX	
Α	2.95	3.10	0.116	0.122	
В	1.55	1.70	0.061	0.067	
С	1.00	1.10	0.039	0.043	
D	0.25	0.35	0.010	0.014	
G	0.65 BSC		0.025 BSC		
J	0.10	0.20	0.004	0.008	
K	0.28	0.42	0.011	0.017	
L	0.55 BSC		0.022 BSC		
M	5 °	5° NOM		NOM	
S	1.80	2.00	0.072	0.080	

- STYLE 2:
 PIN 1. SOURCE 1
 2. GATE 1
 3. SOURCE
 4. GATE 2
 5. DRAIN 1
 6. DRAIN 1
 7. DRAIN 2
 8. DRAIN 2

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